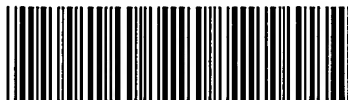


**Search Notes**

Application/Control No.

10/675,784

Examiner

Christopher B. Shin

Applicant(s)/Patent under  
Reexamination

BAUMAN ET AL.

Art Unit

2182

**SEARCHED**

Class	Subclass	Date	Examiner
710	1,6,22-24	8/24/2005	CBS
710	33-35,41	8/24/2005	CBS
710	52-56	8/24/2005	CBS
711	3,141-159	8/24/2005	CBS
711	163-169	8/24/2005	CBS
718	101-105	8/24/2005	CBS
718	108	8/24/2005	CBS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM - INVENTIOR SEARCHED FOR DOUBLE PATENTING	8/22/2005	CBS
PLUS	8/23/2005	CBS
EAST(USPGPUB, UEPAT, USOCR, EPO, JPO, DERWENT, IBM-TDB)	8/24/2005	CSB